

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 7,051,239 B2
APPLICATION NO. : 10/034717
DATED : May 23, 2006
INVENTOR(S) : Timothe Litt

Page 1 of 4

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

The title page should be deleted and substitute therefore the attached title page.

Sheet 1 of 5 – Drawings

Fig. 1, replace with the following figure:

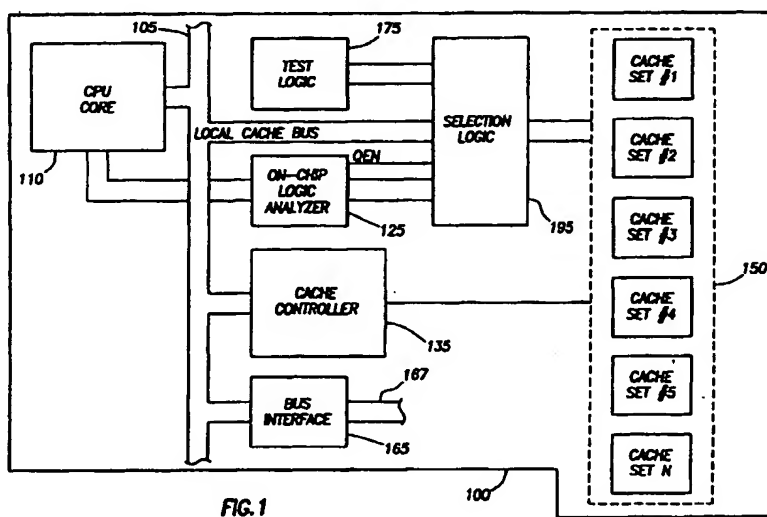


FIG. 1

Sheet 2 of 5 – Drawings

Fig. 2, replace with the following figure:

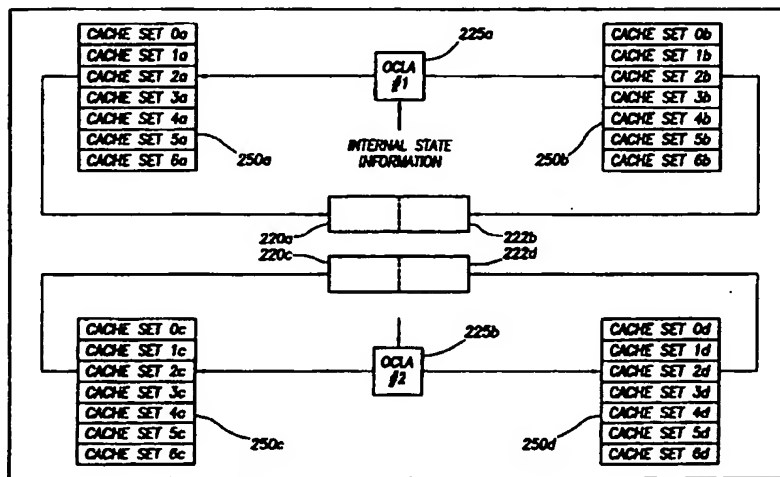


FIG. 2

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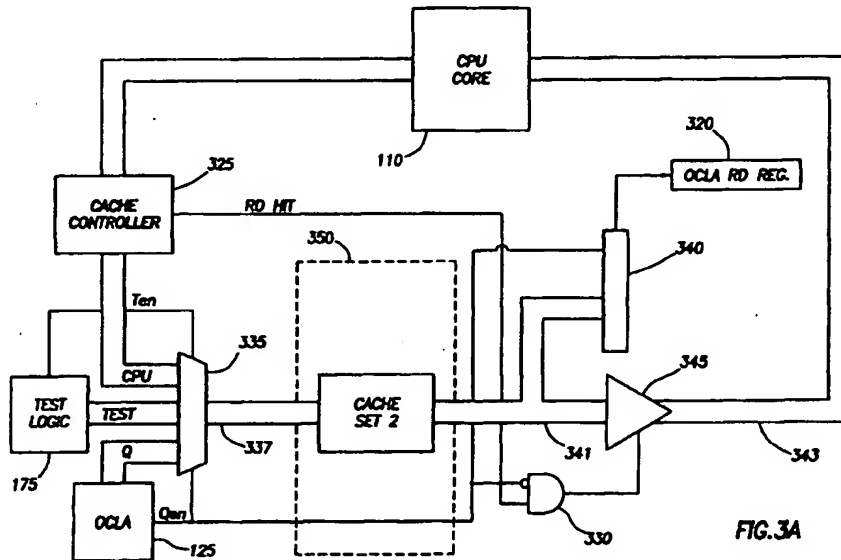
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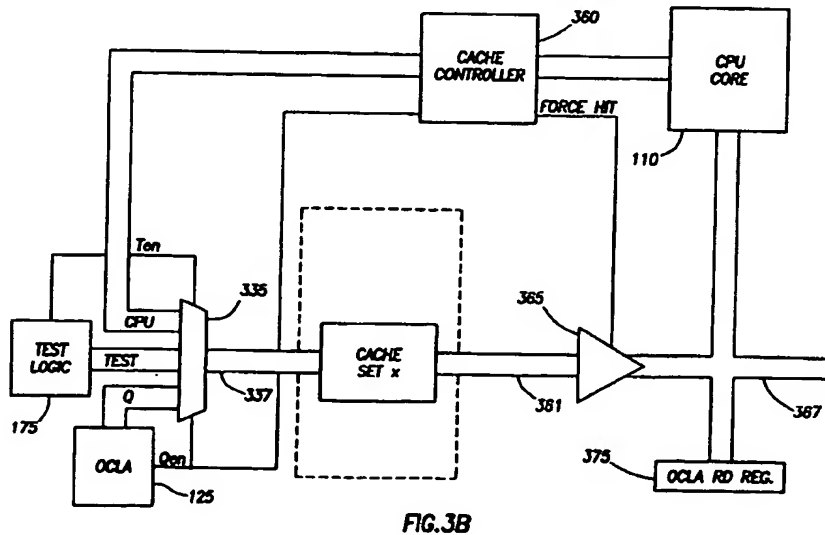
Sheet 3 of 5 – Drawings

Fig. 3A, replace with the following figure:



Sheet 4 of 5 – Drawings

Fig. 3B, replace with the following figure:



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Sheet 5 of 5 – Drawings

Fig. 4, replace with the following figure:

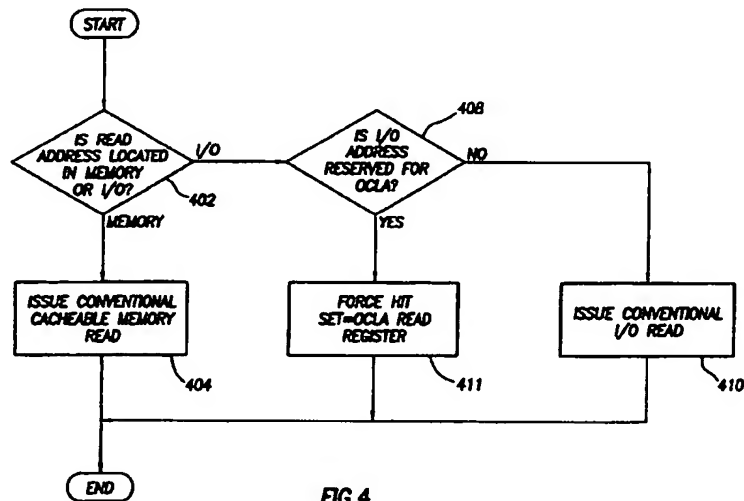


FIG. 4

Signed and Sealed this

Fifth Day of December, 2006

JON W. DUDAS
Director of the United States Patent and Trademark Office

(12) **United States Patent**
Litt

(10) **Patent No.:** **US 7,051,239 B2**
(45) **Date of Patent:** **May 23, 2006**

(54) **METHOD AND APPARATUS FOR
EFFICIENTLY IMPLEMENTING TRACE
AND/OR LOGIC ANALYSIS MECHANISMS
ON A PROCESSOR CHIP**

(75) **Inventor:** **Timothe Litt, Southborough, MA (US)**

(73) **Assignee:** **Hewlett-Packard Development
Company, L.P., Houston, TX (US)**

(*) **Notice:** Subject to any disclaimer, the term of this
patent is extended or adjusted under 35
U.S.C. 154(b) by 658 days.

(21) **Appl. No.:** **10/034,717**

(22) **Filed:** **Dec. 28, 2001**

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(51) **Int. Cl.**
G06F 11/00 (2006.01)

(52) **U.S. Cl.** **714/42; 714/30; 714/33;
714/41**

(58) **Field of Classification Search** **714/30,
714/33, 42, 41**

See application file for complete search history.

(56) **References Cited**

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Primary Examiner—Scott Baderman

Assistant Examiner—Timothy M Bonura

(57) **ABSTRACT**

A system is disclosed in which an on-chip logic analyzer (OCLA) is included in an integrated circuit, such as a microprocessor. During debug modes, one or more sets of an on-chip cache memory are disabled from use by other circuitry in the integrated circuit, and reserved exclusively for use by the OCLA. Data stored in the reserved cache set can then be read out by the OCLA, and placed in a register that can be accessed by other logic internal or external to the integrated circuit. If the integrated circuit is operating under normal mode, the cache memory set can be used in conventional fashion by other circuitry within the integrated circuit to enhance performance.

22 Claims, 5 Drawing Sheets

